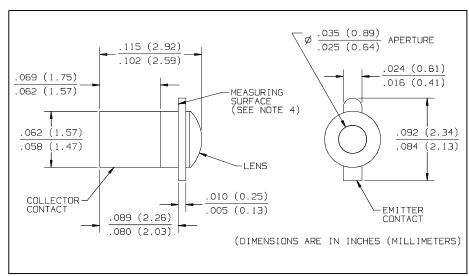


## **Hi-Reliability NPN Silicon Phototransistors** Types OP602TX/V, OP603TX/V, OP604TX/V, OP604S





#### **Features**

- Processed to Optek's military screening program patterned after MIL-PRF-19500
- Miniature hermetically sealed package
- Wide range of collector currents
- Ideal for direct mounting in PC boards

#### Description

Each device in this series consists of a high reliability NPN silicon phototransistor mounted in a miniature glass lensed, hermetically sealed, "Pill" package.

After electrical testing by manufacturing, all devices are processed to Optek's 100% screening program patterned after MIL-PRF-19500. Typical screening and lot acceptance tests are provided on page 13-4.

This device type is lensed and has an acceptance half angle of 18° measured from the optical axis to the half power point. The series is also mechanically and spectrally matched to the OP223 and OP224 high reliability series of infrared emitting diodes.

### **Absolute Maximum Ratings** (T<sub>A</sub> = 25<sup>o</sup> C unless otherwise noted)

Storage Temperature Range65° C to +150° C	С
Operating Temperature Range55° C to +125° C	Э
Collector-Emitter Voltage	
Emitter-Collector Voltage	V
Soldering Temperature (for 5 seconds with soldering iron)	)
Power Dissipation	-)
Notes:	

- (1) No-clean or low solids, RMA flux is recommended. Duration can be extended to 10 sec. max. when wave soldering.

  Derate linearly 0.5 mW/° C above 25° C.
- (3) Junction temperature maintained at 25° C.
- (4) Light source is an unfiltered tungsten lamp operating at CT = 2870 K or equivalent source.

# II-REL OPTO

## Types OP602TX/V, OP603TX/V, OP604TX/V, OP604S

**Electrical Characteristics** (T<sub>A</sub> = 25° C unless otherwise noted)

Symbol	Parameter	Min	Тур	Max	Units	Test Conditions
IC(on)	On-State Collector Current OP602TX,TXV OP603TX,TXV OP604TX,TXV, S	2.0 4.0 7.0		5.0 8.0	mA mA mA	$\begin{split} &\text{V}_{\text{CE}} = 5.0 \text{ V}, \text{ E}_{\text{e}} = 20 \text{ mW/cm}^{2(3)(4)} \\ &\text{V}_{\text{CE}} = 5.0 \text{ V}, \text{ E}_{\text{e}} = 20 \text{ mW/cm}^{2(3)(4)} \\ &\text{V}_{\text{CE}} = 5.0 \text{ V}, \text{ E}_{\text{e}} = 20 \text{ mW/cm}^{2(3)(4)} \end{split}$
I <sub>CEO</sub>	Collector Dark Current			25 100	nA μA	V <sub>CE</sub> = 10.0 V, E <sub>e</sub> = 0 V <sub>CE</sub> = 30.0 V, E <sub>e</sub> = 0, T <sub>A</sub> = 100° C
$V_{(BR)CEO}$	Collector-Emitter Breakdown Voltage	50			V	$I_C = 100 \mu\text{A},  E_e = 0$
V <sub>(BR)ECO</sub>	Emitter-Collector Breakdown Voltage	7.0			V	$I_E = 100 \mu\text{A},  E_e = 0$
V <sub>CE(SAT)</sub>	Collector-Emitter Saturation Voltage			0.40	V	$I_C = 0.4 \text{ mA}, E_e = 20 \text{ mW/cm}^{2(3)(4)}$
t <sub>r</sub>	Rise Time			20.0	μs	V <sub>CC</sub> = 30 V, I <sub>C</sub> = 1.00 mA,
t <sub>f</sub>	Fall Time			20.0	μs	$R_L = 100 \Omega$